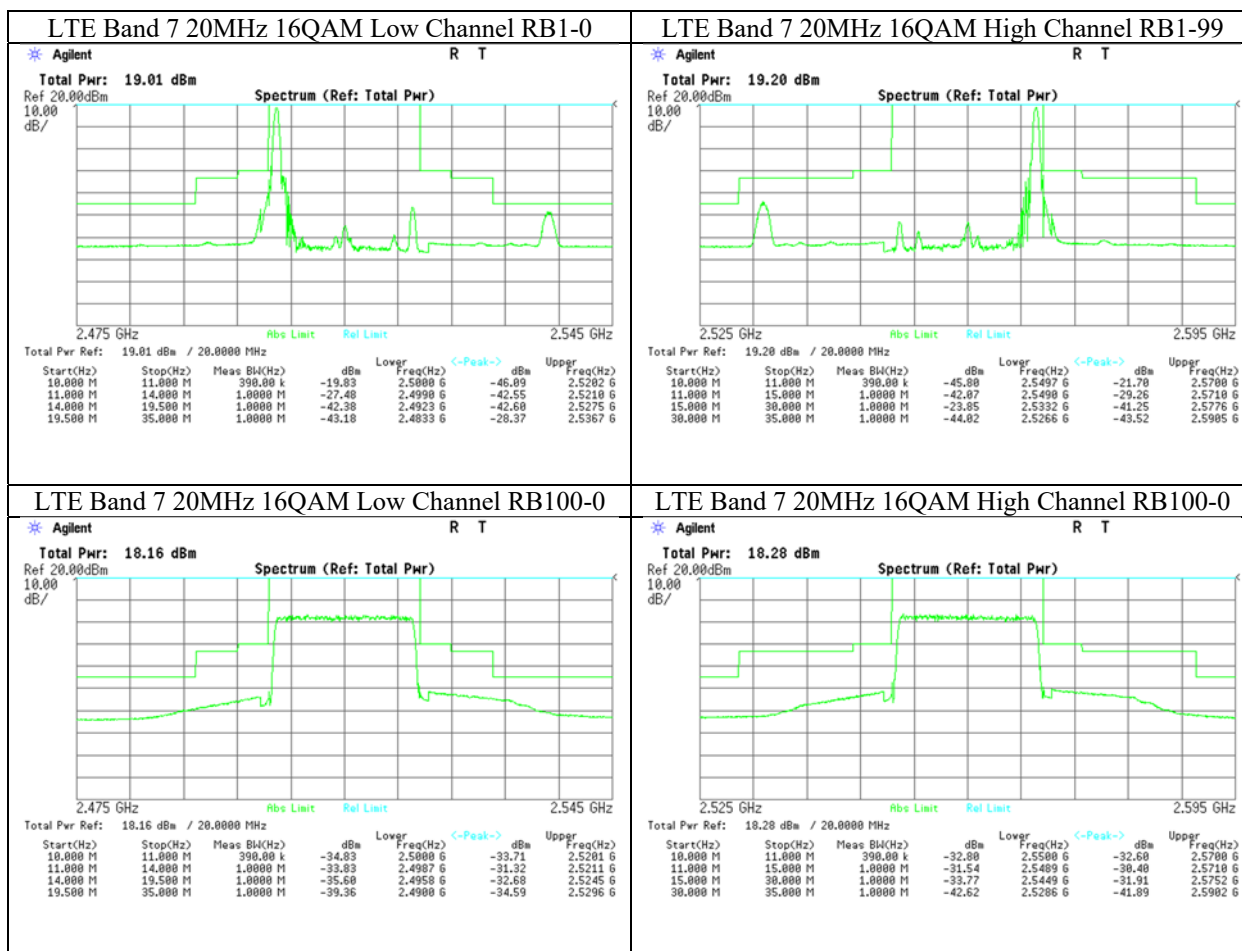


Band Edge (Conducted)

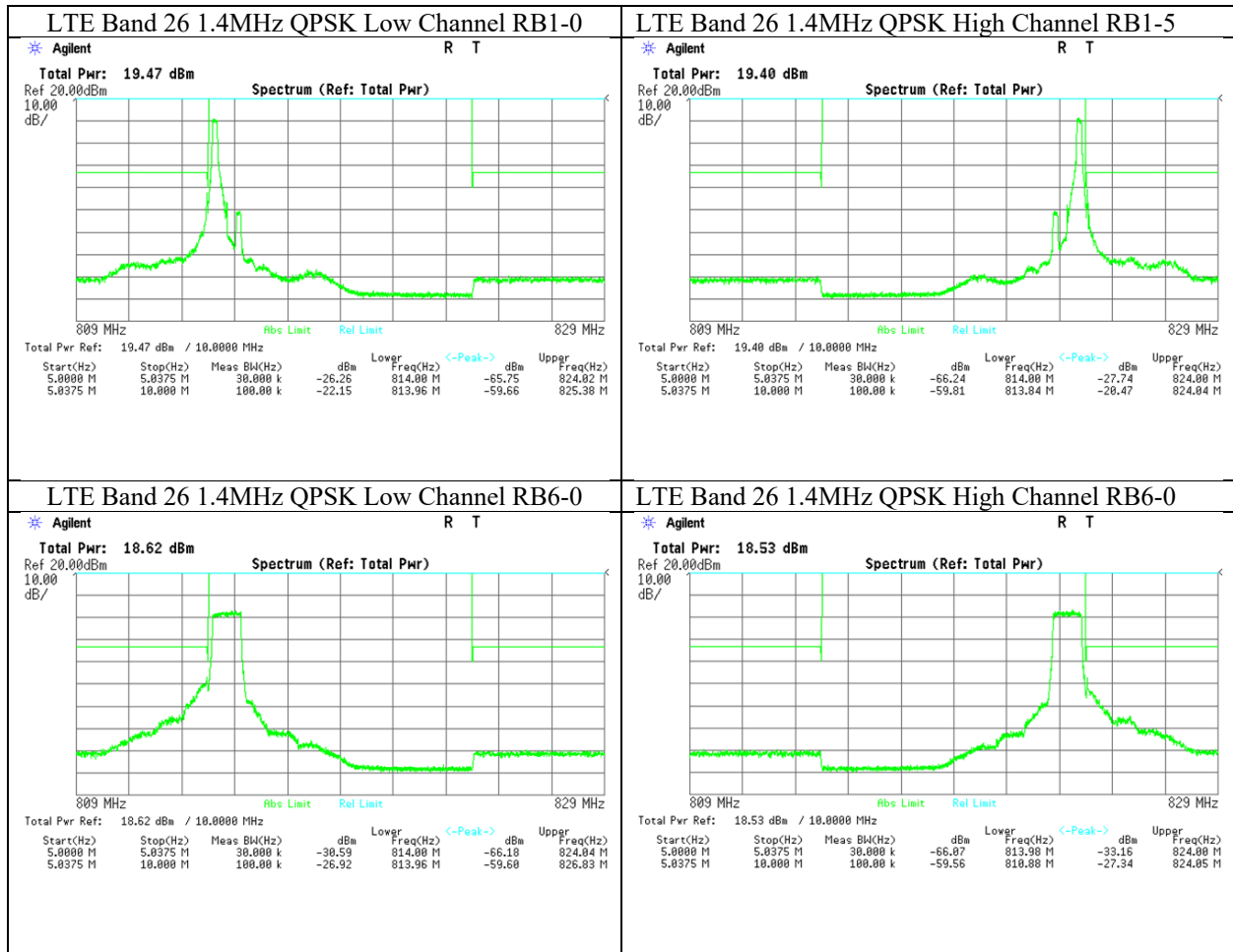
Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 19, 2020
Temperature / Humidity 22 deg. C / 46 % RH
Engineer Tomohisa Nakagawa

Mode LTE



Band Edge (Conducted)

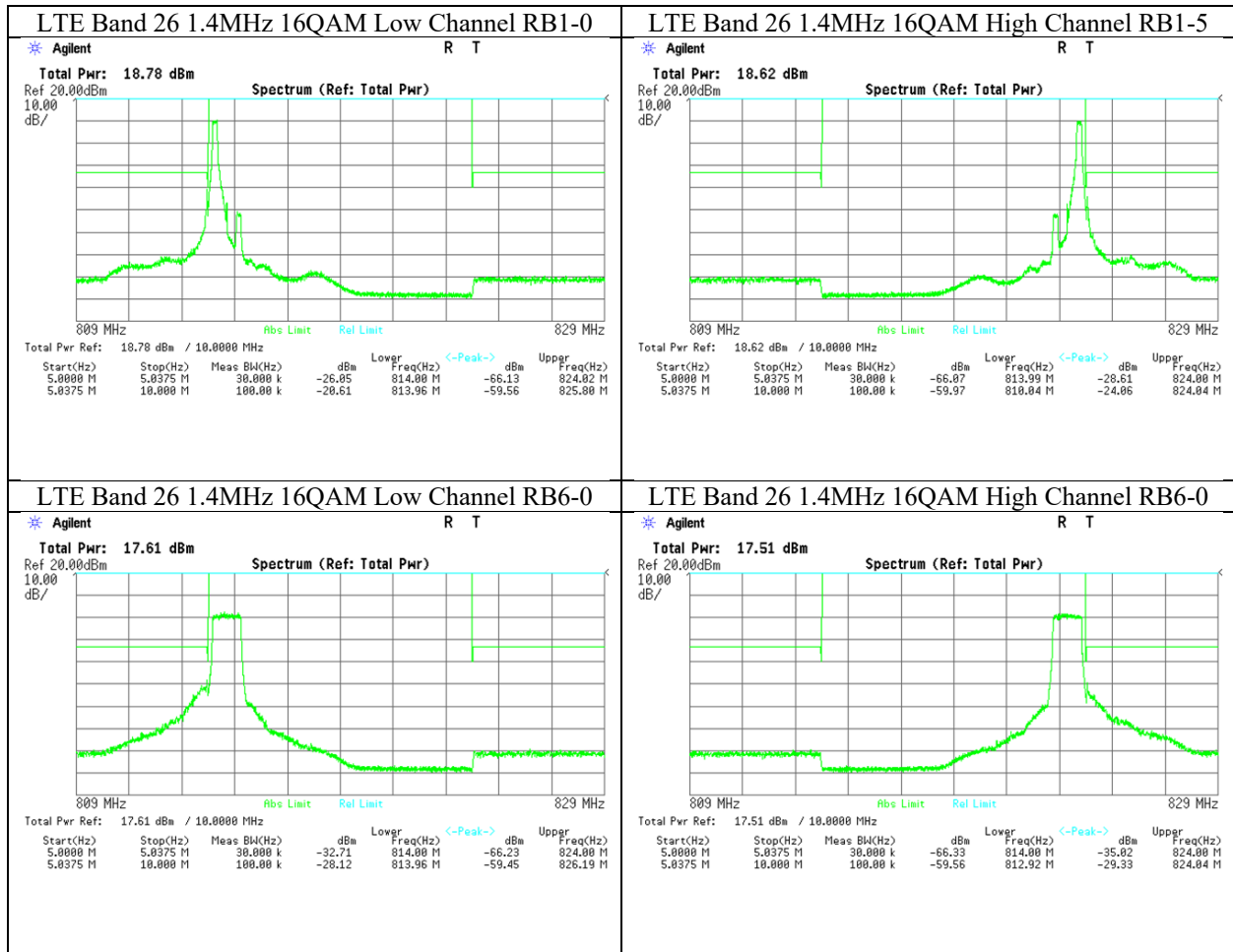
Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 20, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa
Mode LTE



Band Edge (Conducted)

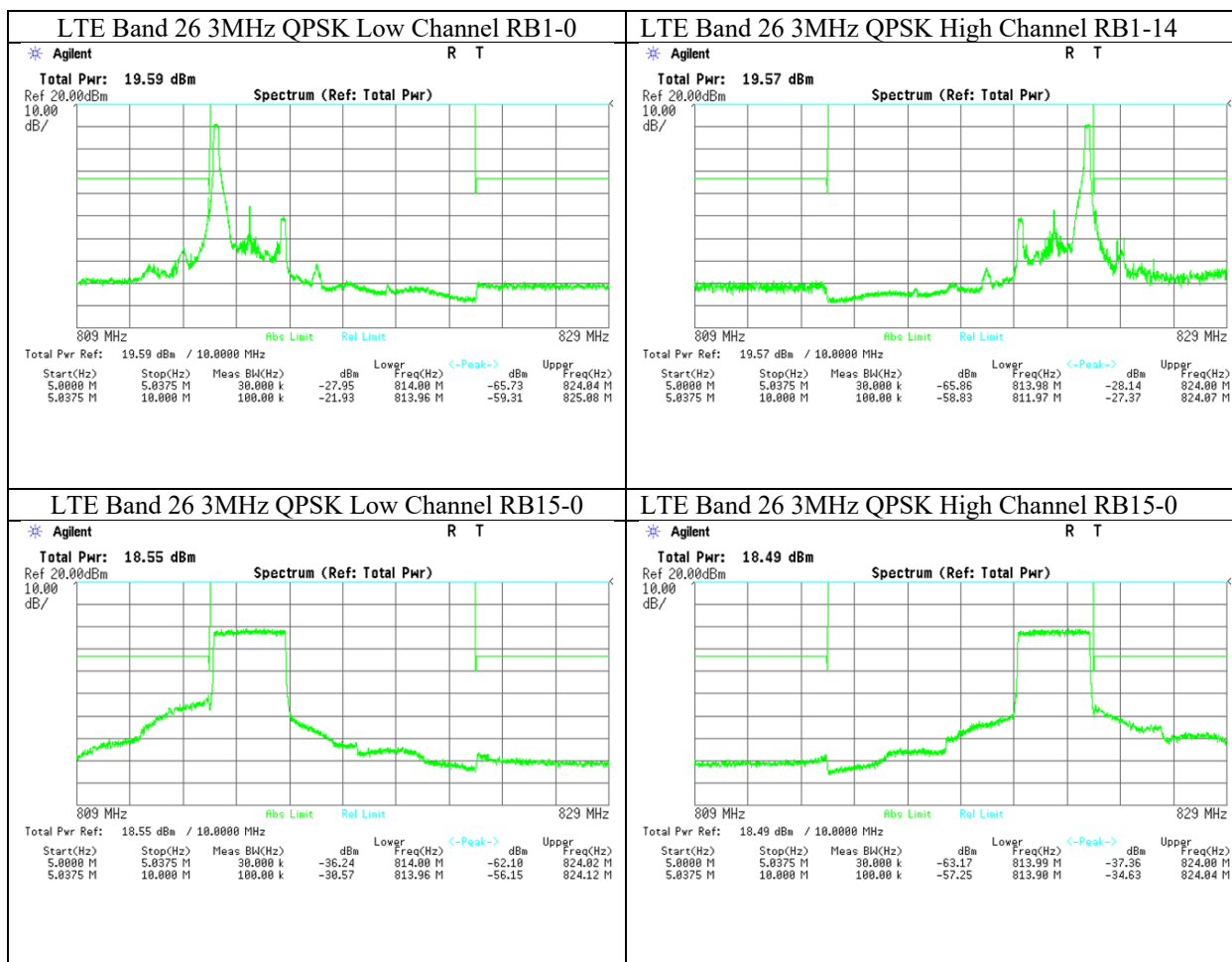
Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 20, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa

Mode LTE



Band Edge (Conducted)

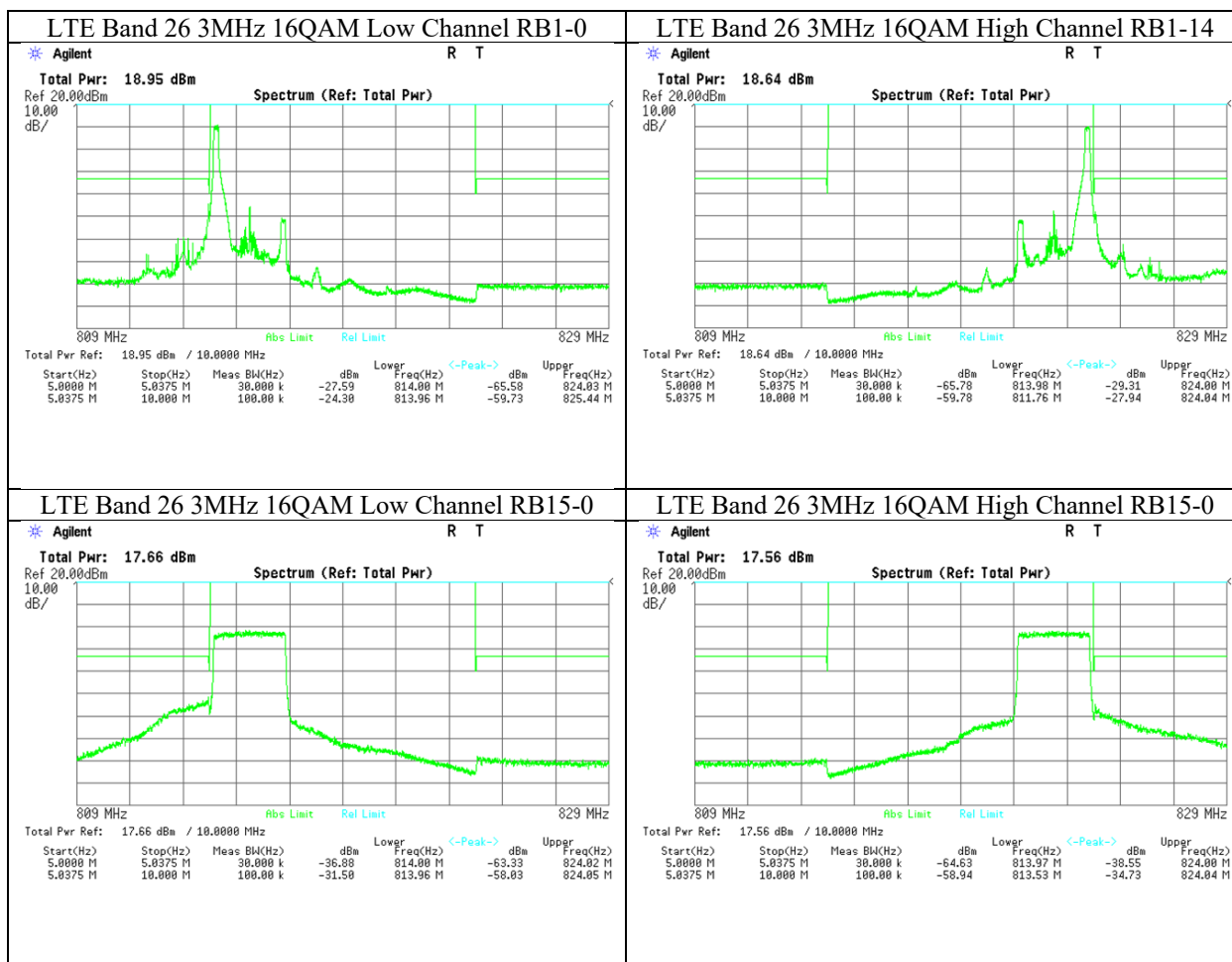
Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 20, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa
Mode LTE



Band Edge (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 20, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa

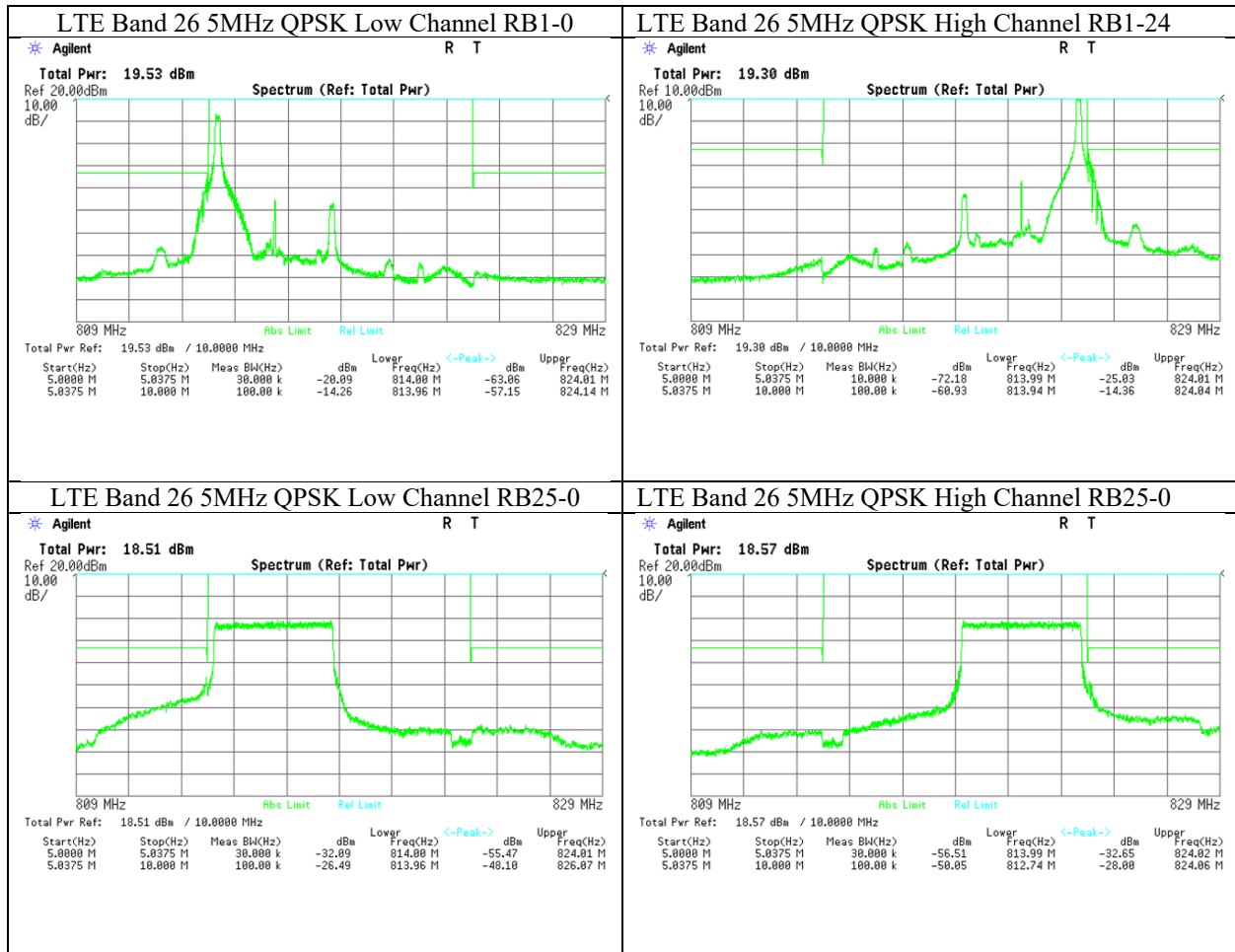
Mode LTE



Band Edge (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 20, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa

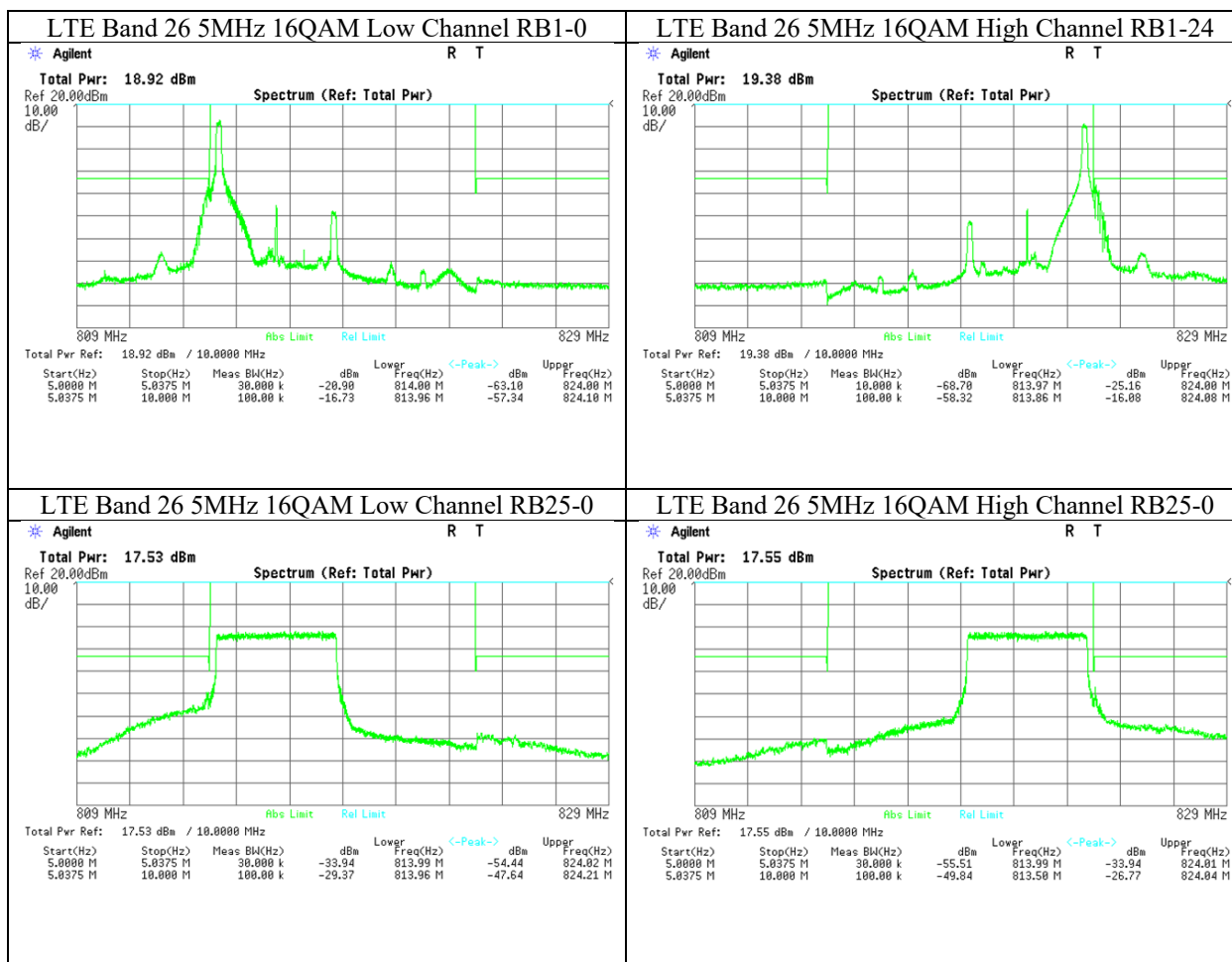
Mode LTE



Band Edge (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 20, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa

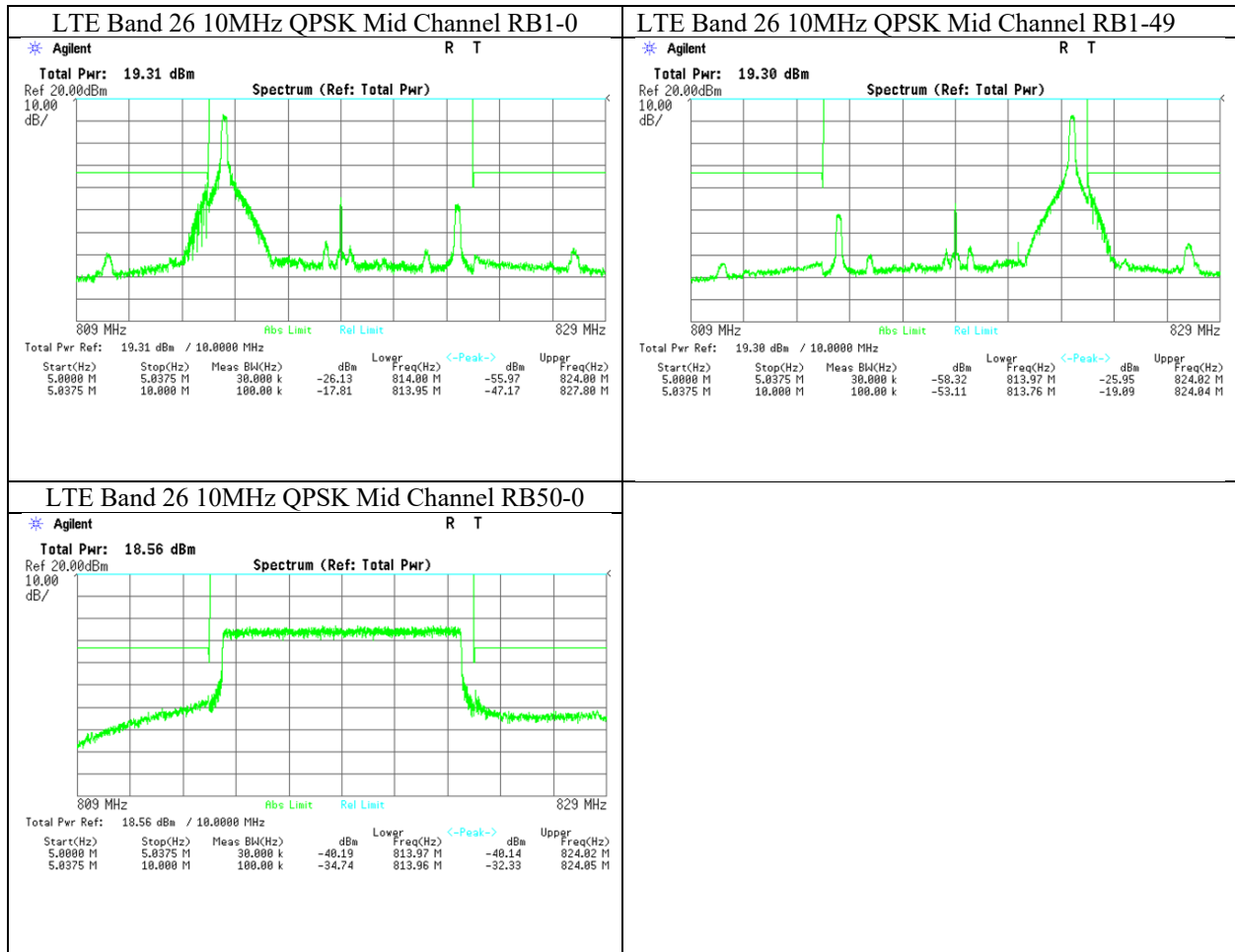
Mode LTE



Band Edge (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 20, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa

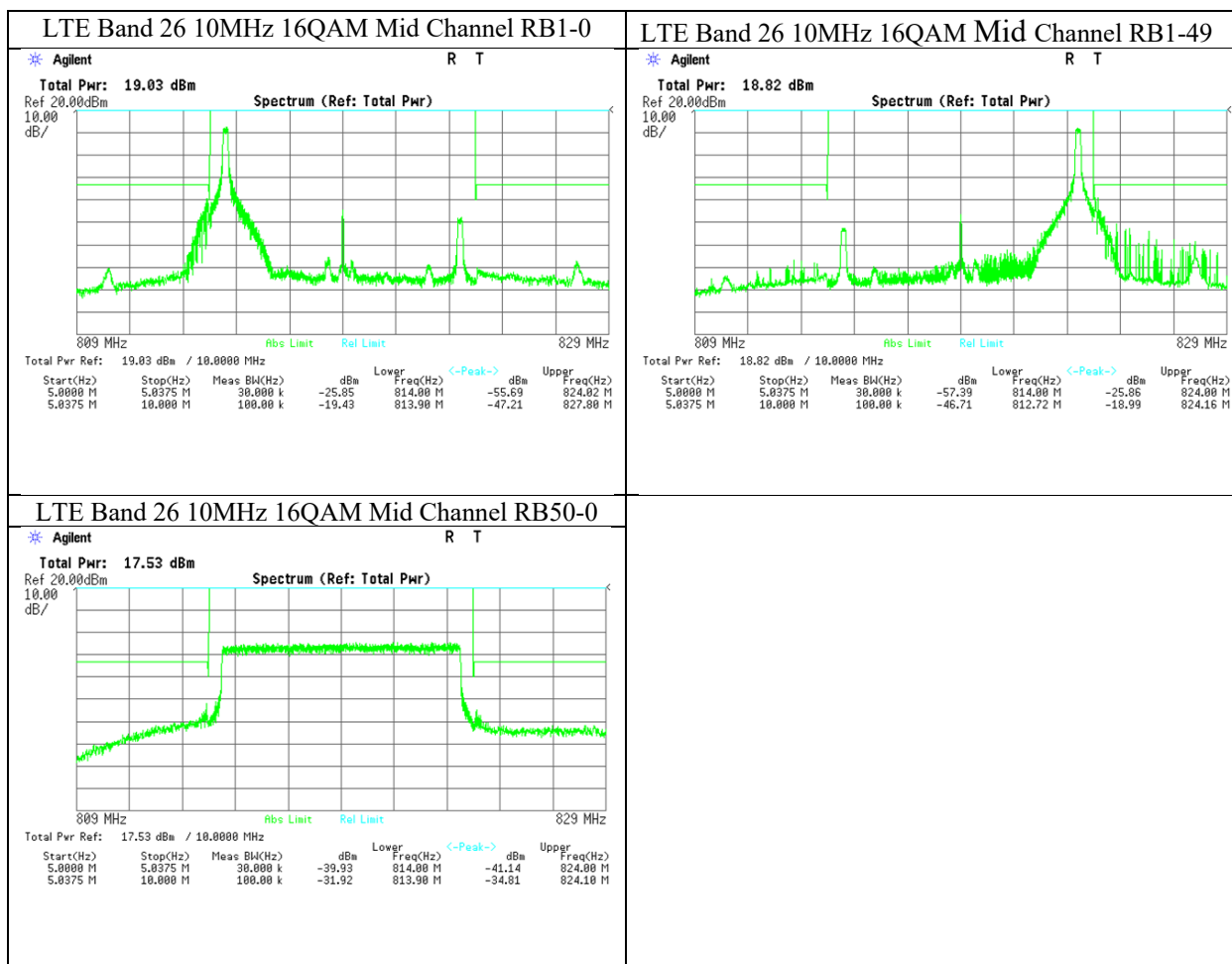
Mode LTE



Band Edge (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 20, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa

Mode LTE



Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.5
Date April 2, 2020
Temperature / Humidity 23 deg. C / 40 % RH
Engineer Yutaka Yoshida
Mode GSM



Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.5
Date April 2, 2020
Temperature / Humidity 23 deg. C / 40 % RH
Engineer Yutaka Yoshida
Mode GSM



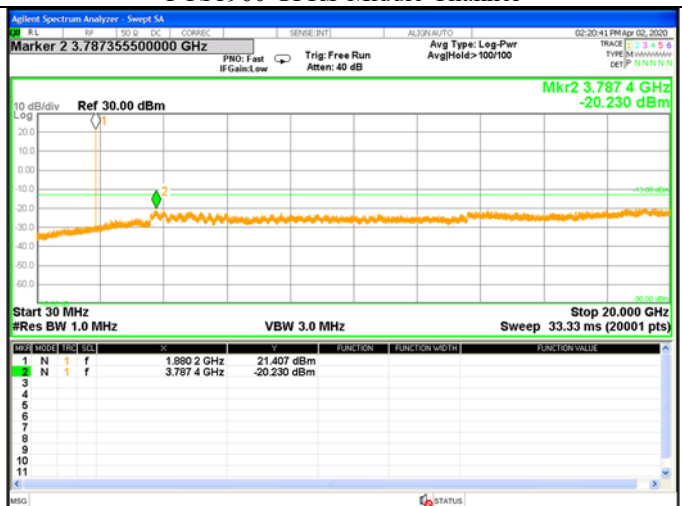
Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.5
Date April 2, 2020
Temperature / Humidity 22 deg. C / 40 % RH
Engineer Yutaka Yoshida
Mode GSM

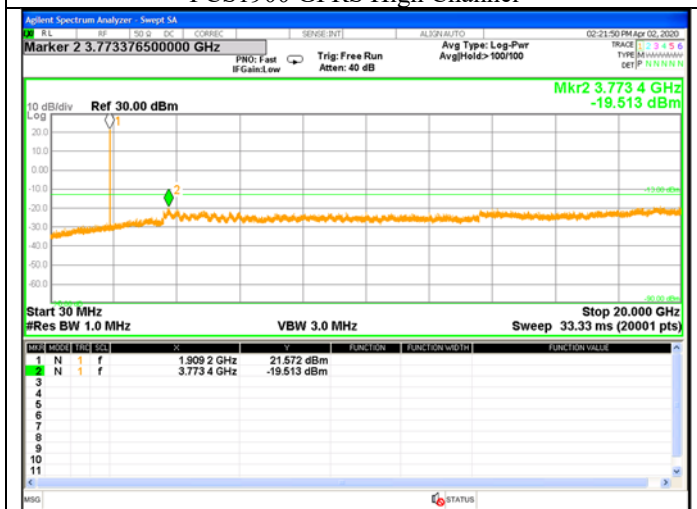
PCS1900 GPRS Low Channel



PCS1900 GPRS Middle Channel



PCS1900 GPRS High Channel



Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.5
Date April 2, 2020
Temperature / Humidity 23 deg. C / 40 % RH
Engineer Yutaka Yoshida
Mode GSM



UL Japan, Inc.

Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 16, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa
Mode W-CDMA



UL Japan, Inc.

Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 17, 2020
Temperature / Humidity 22 deg. C / 43 % RH
Engineer Tomohisa Nakagawa
Mode W-CDMA



UL Japan, Inc.

Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

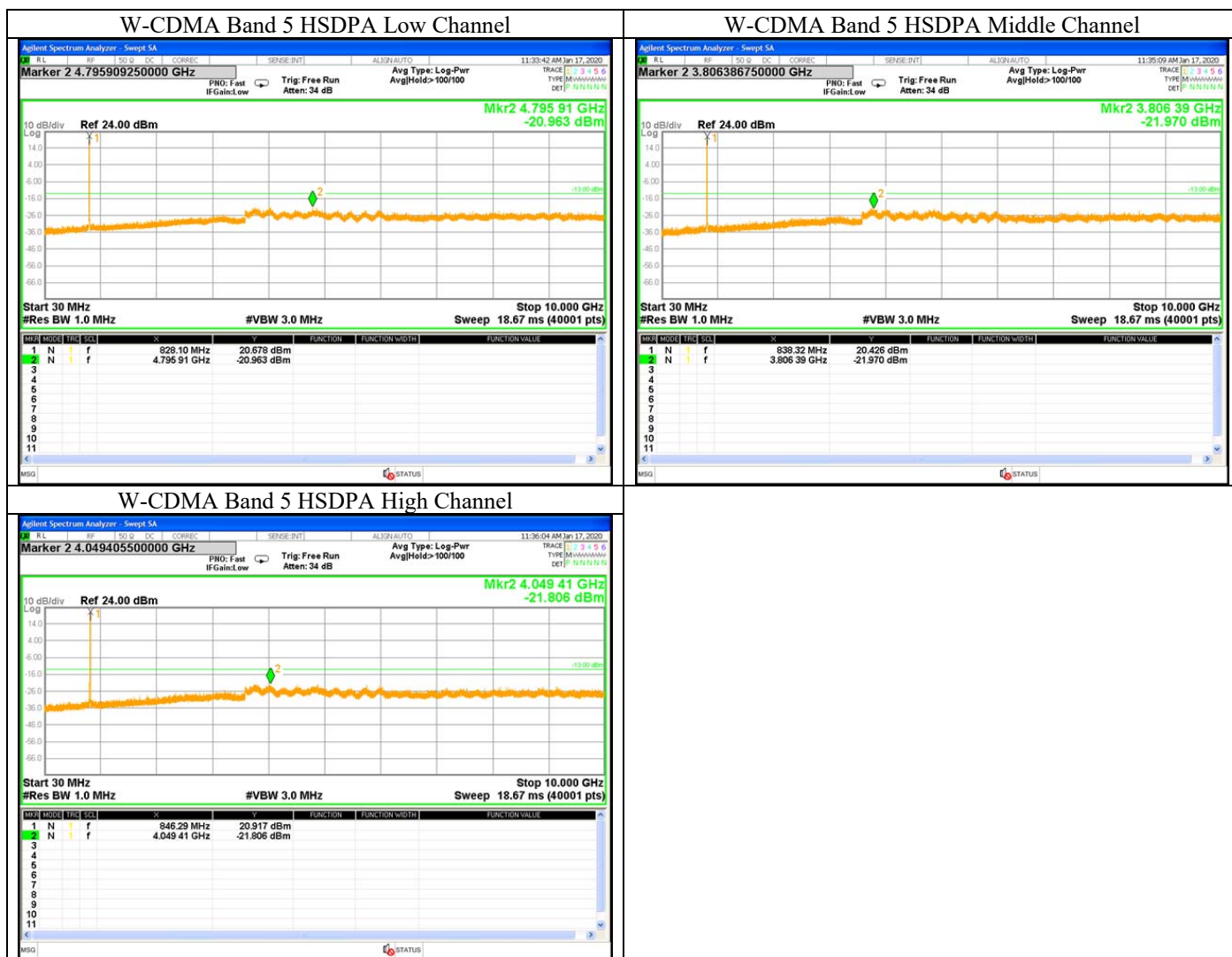
Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 16, 2020
Temperature / Humidity 22 deg. C / 45 % RH
Engineer Tomohisa Nakagawa
Mode W-CDMA



Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 17, 2020
Temperature / Humidity 22 deg. C / 43 % RH
Engineer Tomohisa Nakagawa
Mode W-CDMA



UL Japan, Inc.

Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



UL Japan, Inc.

Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



UL Japan, Inc.

Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



UL Japan, Inc.

Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

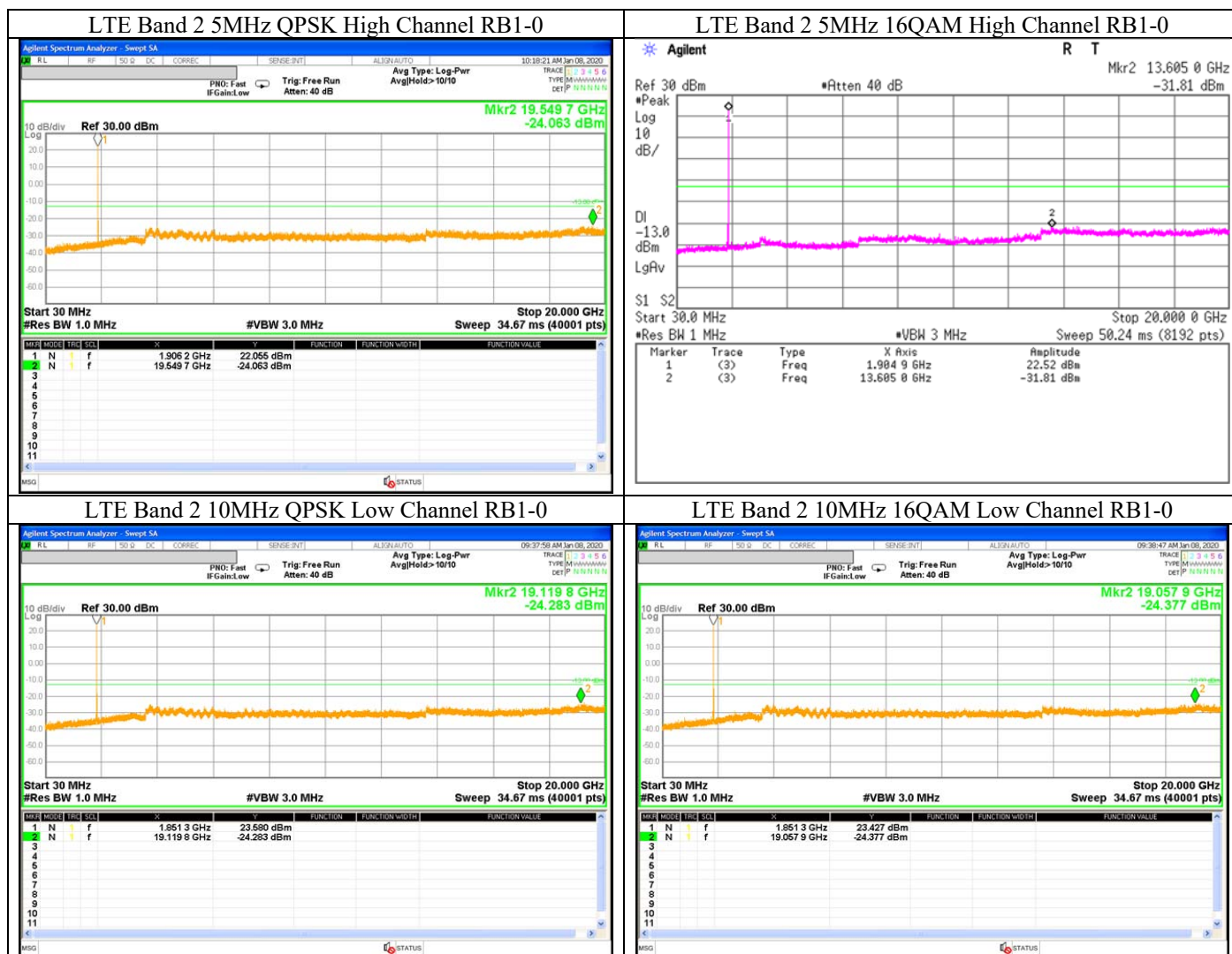
Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



Spurious Emission (Conducted)

Report No.	13274888H	No.6
Test place	Ise EMC Lab.	No.6
Shielded Room	No.6	March 6, 2020
Date	January 8, 2020	22 deg. C / 44 % RH
Temperature / Humidity	23 deg. C / 54 % RH	Yutaka Yoshida
Engineer	Yutaka Yoshida	Yutaka Yoshida
Mode	LTE	



UL Japan, Inc.

Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



UL Japan, Inc.

Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



UL Japan, Inc.

Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

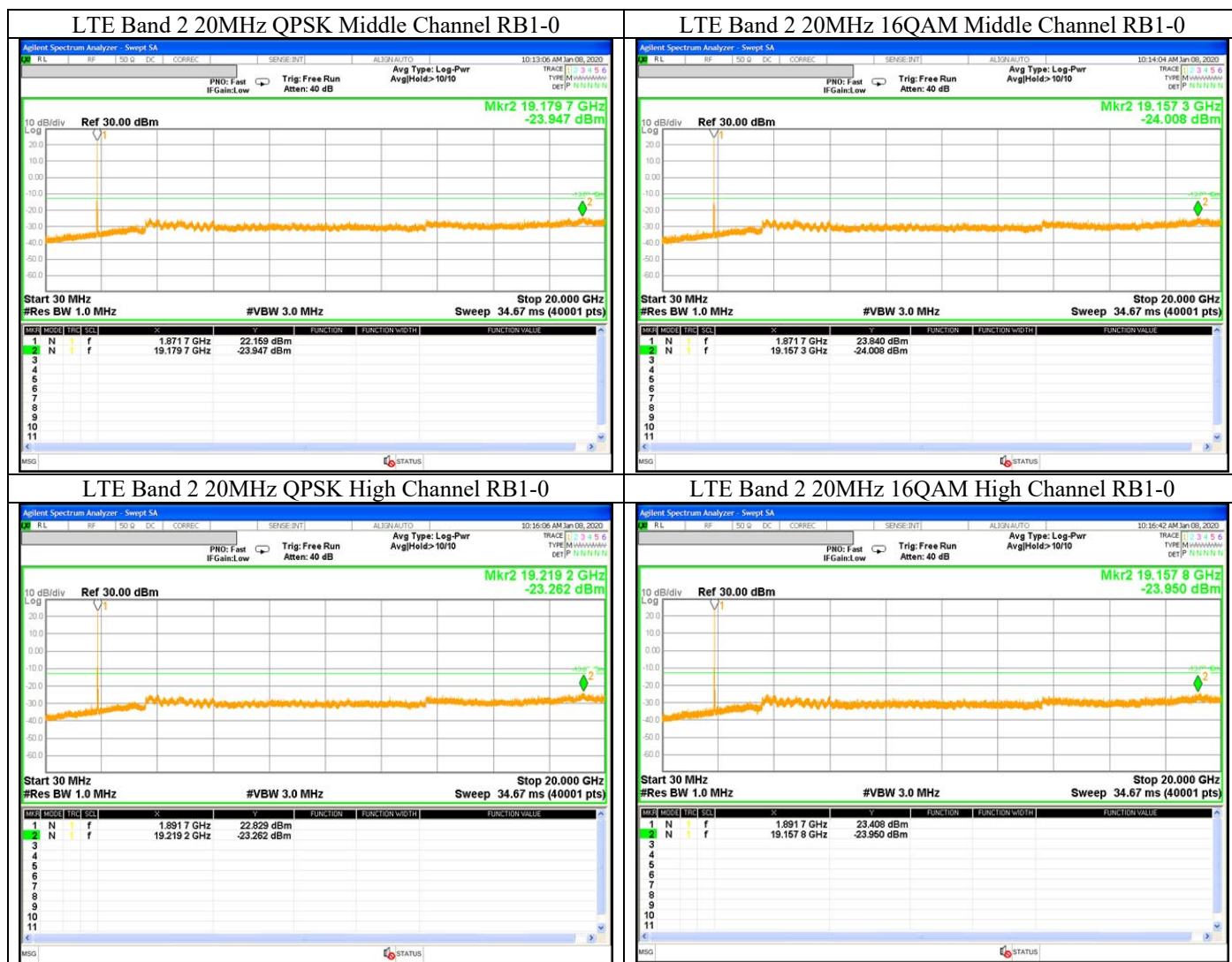
Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



UL Japan, Inc.

Ise EMC Lab.

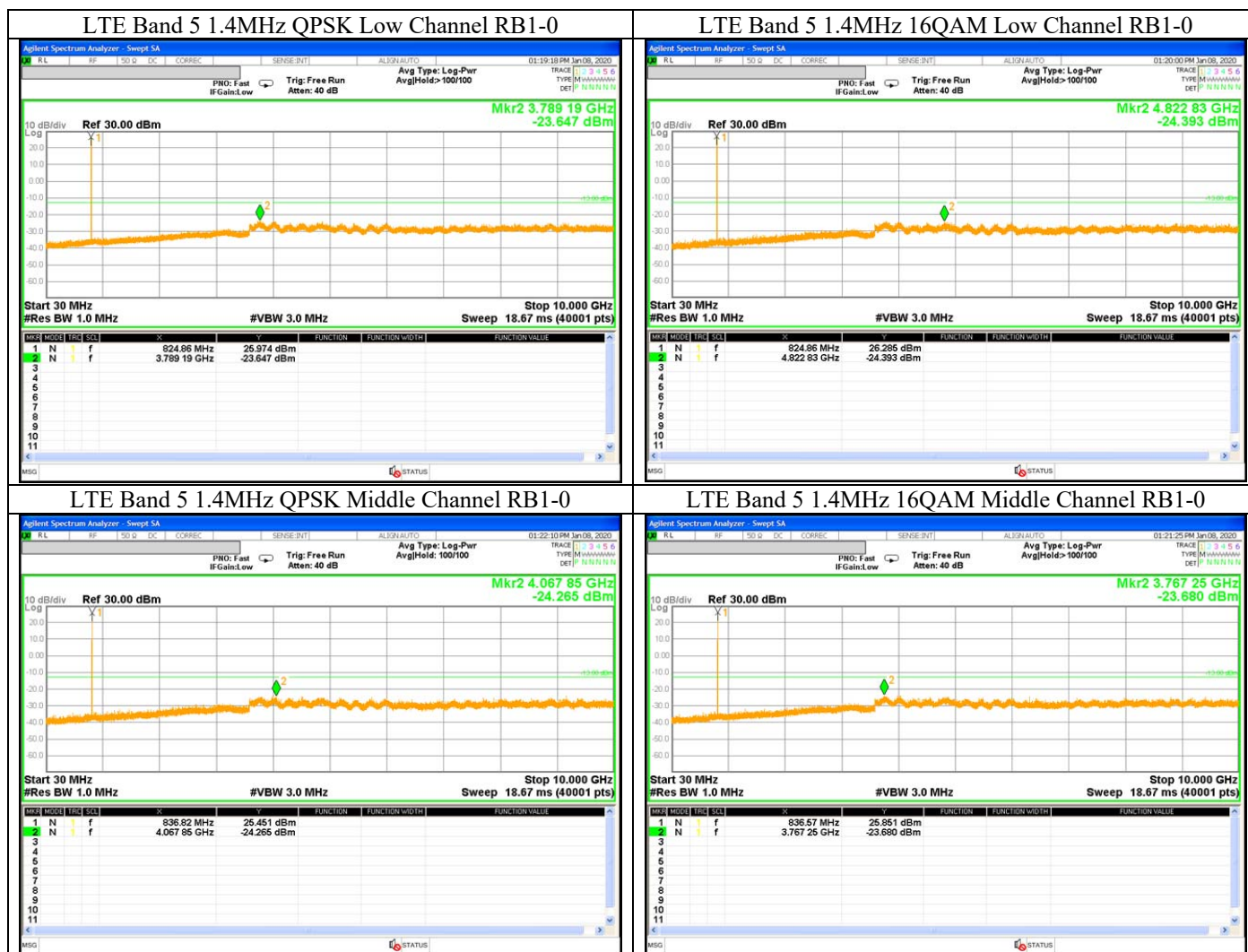
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



UL Japan, Inc.

Ise EMC Lab.

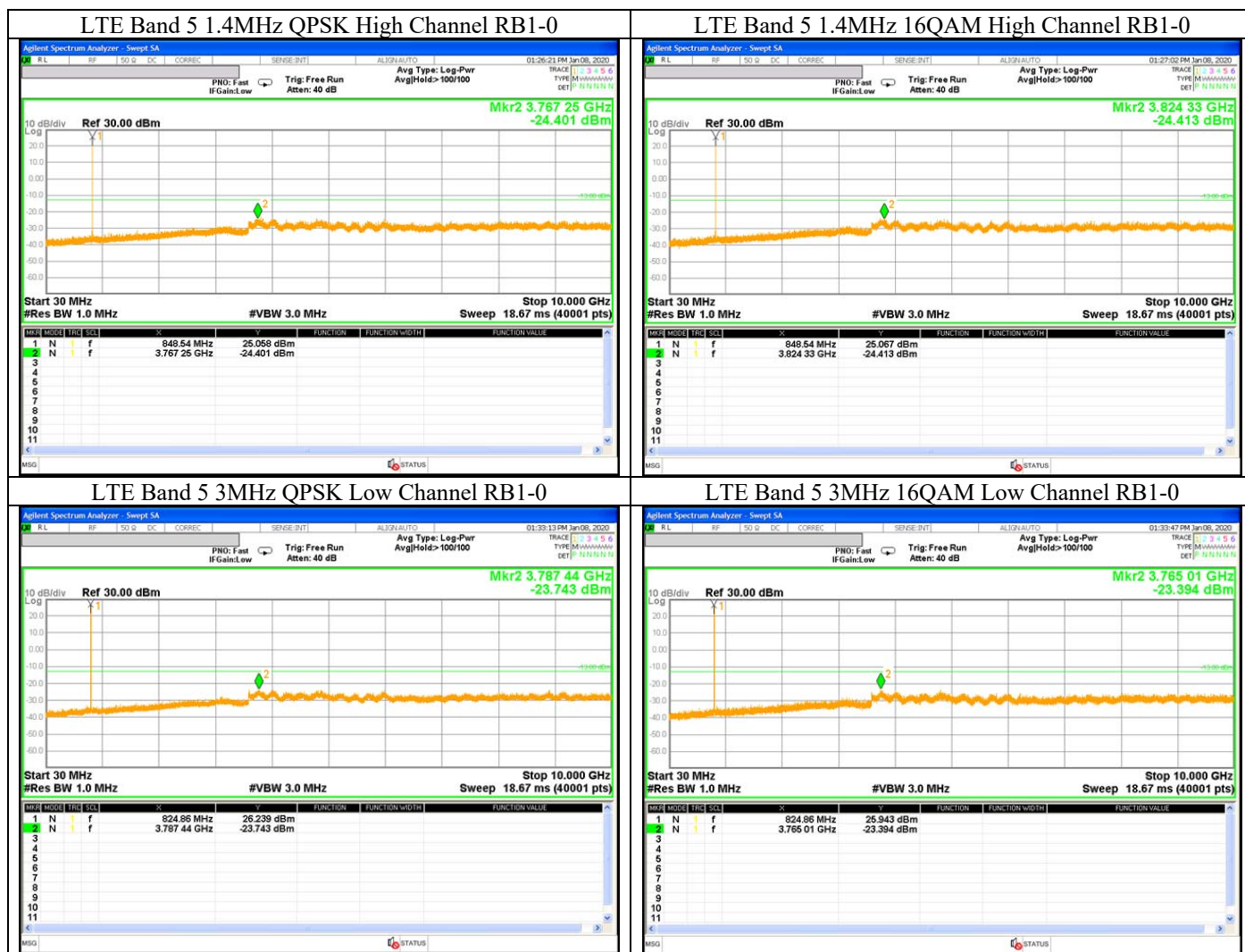
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Spurious Emission (Conducted)

Report No. 13274888H
Test place Ise EMC Lab.
Shielded Room No.6
Date January 8, 2020
Temperature / Humidity 23 deg. C / 54 % RH
Engineer Yutaka Yoshida
Mode LTE



UL Japan, Inc.

Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124